

## Vienna Rectifier MOSFET Power Module

### Super junction MOSFET:

$V_{DSS} = 600V$  ;  $R_{DSon} = 99m\Omega$  Max @  $T_j = 25^\circ C$   
 $I_D = 28A$  @  $T_c = 25^\circ C$

#### Application

- Power supply

#### Features

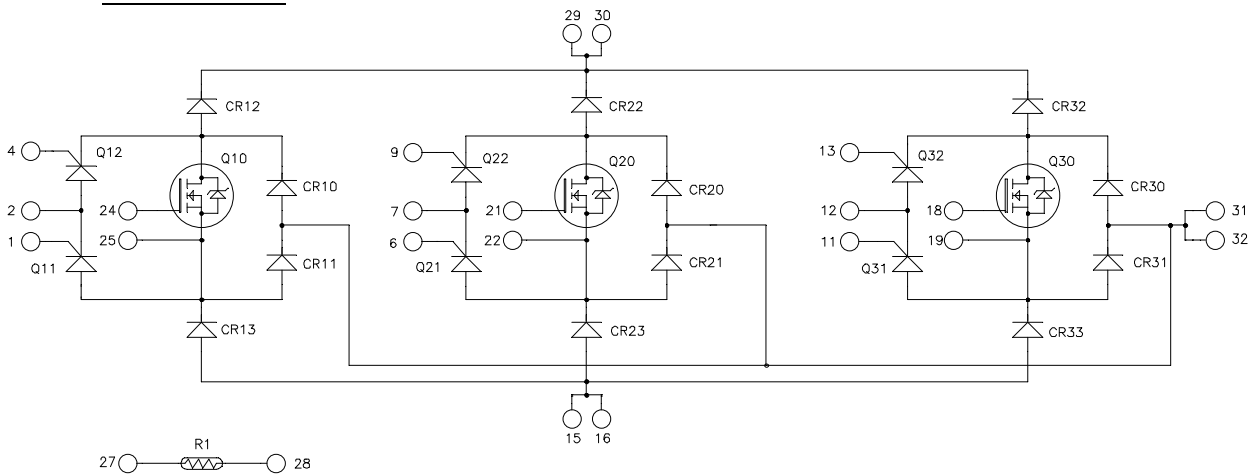
- **Super junction MOSFET**
  - Ultra low  $R_{DSon}$
  - Low Miller capacitance
  - Ultra low gate charge
  - Avalanche energy rated
  - Very rugged
- **SiC Schottky diode**
  - Zero reverse recovery
  - Zero forward recovery
  - Temp. Independent switching behavior
  - Positive temperature coefficient on VF

- AlN substrate for improved thermal performance
- Internal thermistor for temperature monitoring
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration

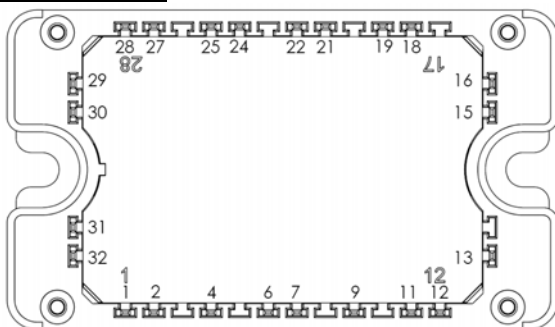
#### Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- RoHS Compliant

#### Electrical scheme:



#### Pin out Location:



**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

All ratings @  $T_j = 25^\circ C$  unless otherwise specified

## 1. Absolute maximum ratings

**Thyristor** (per thyristor) Absolute maximum ratings

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>	
V <sub>DRM</sub>	Repetitive Peak Reverse Voltage	1200	V	
I <sub>DRM</sub>	Repetitive Peak Reverse Current	1	mA	
I <sub>TRMS</sub>	RMS on – state current	T <sub>J</sub> = 80°C	40	A
I <sub>TSM</sub>	Surge on – state current	t = 10ms T <sub>C</sub> = 45°C	300	A
V <sub>RGM</sub>	Peak Reverse Gate Voltage	10	V	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25°C	186	W

**Super junction MOSFET** (per MOSFET) Absolute maximum ratings

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>	
V <sub>DSS</sub>	Drain - Source Breakdown Voltage	600	V	
I <sub>D</sub>	Continuous Drain Current	T <sub>c</sub> = 25°C	28	A
		T <sub>c</sub> = 80°C	22	
I <sub>DM</sub>	Pulsed Drain current	75		
V <sub>GS</sub>	Gate - Source Voltage	±20	V	
R <sub>DSon</sub>	Drain - Source ON Resistance	99	mΩ	
P <sub>D</sub>	Maximum Power Dissipation	T <sub>c</sub> = 25°C	155	W
I <sub>AR</sub>	Avalanche current (repetitive and non repetitive)	11	A	
E <sub>AR</sub>	Repetitive Avalanche Energy	1.2	mJ	
E <sub>AS</sub>	Single Pulse Avalanche Energy	800		

**SiC Diode** (CR12/13, CR22/23, CR32/33) (per diode) Absolute maximum ratings

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>	
V <sub>R</sub>	DC reverse Voltage	600	V	
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage			
I <sub>F</sub>	DC Forward Current	T <sub>C</sub> = 125°C	10	A
I <sub>FRM</sub>	Repetitive Peak Forward Current	tp = 10ms	50	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25°C	68	W

**FRED diode** (CR10/11, CR20/21, CR30/31) (per diode) Absolute maximum ratings

<i>Symbol</i>	<i>Parameter</i>	<i>Max ratings</i>	<i>Unit</i>	
V <sub>R</sub>	DC reverse Voltage	600	V	
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage			
I <sub>F</sub>	DC Forward Current	T <sub>C</sub> = 100°C	30	A
I <sub>FRM</sub>	Repetitive Peak Forward Current	tp = 1ms	60	
P <sub>D</sub>	Power Dissipation	T <sub>C</sub> = 25°C	107	W

## 2. Electrical Characteristics

### Thyristor (per thyristor) Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$V_T$	On – state Voltage	$I_T = 20A$	$T_J = 25^\circ C$		1.55		V
$V_{TO}$	Direct On state threshold Voltage		$T_J = 125^\circ C$		0.90		
$r_T$	On – state Slope resistance				18		m $\Omega$
$V_{GT}$	Gate Trigger Voltage	$V_D = 6V$	$T_J = 25^\circ C$		1.5		V
$I_{GT}$	Gate Trigger Current				130		mA
$R_{thJC}$	Junction to Case Thermal Resistance					0.67	$^\circ C/W$

### Super junction MOSFET (per MOSFET) Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V ; V_{DS} = 600V$				50	$\mu A$
$R_{DS(on)}$	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 18A$				99	m $\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1.2mA$		2.5	3	3.5	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$				140	nA
$C_{iss}$	Input Capacitance	$V_{GS} = 0V ; V_{DS} = 100V$			2800		pF
$C_{oss}$	Output Capacitance	$f = 1MHz$			130		
$Q_g$	Total gate Charge	$V_{GS} = 10V$			60		nC
$Q_{gs}$	Gate – Source Charge	$V_{Bus} = 400V$			14		
$Q_{gd}$	Gate – Drain Charge	$I_D = 18A$			20		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = 10V$			10		ns
$T_r$	Rise Time	$V_{Bus} = 400V$			5		
$T_{d(off)}$	Turn-off Delay Time	$I_D = 18A$			60		
$T_f$	Fall Time	$R_G = 3.3\Omega$			5		
$R_{thJC}$	Junction to Case Thermal Resistance					0.805	$^\circ C/W$

### SiC Diode (CR12/13, CR22/23, CR32/33) (per SiC diode) Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$I_{RM}$	Reverse Leakage Current	$V_R = 600V$	$T_J = 25^\circ C$		10	60	$\mu A$
			$T_J = 175^\circ C$		20	300	
$V_F$	Diode Forward Voltage	$I_F = 10A$	$T_J = 25^\circ C$		1.6	1.8	V
			$T_J = 175^\circ C$		2	2.4	
$Q_C$	Total Capacitive Charge	$I_F = 10A, V_R = 600V$ $di/dt = 500A/\mu s$			28		nC
C	Total Capacitance	$f = 1MHz, V_R = 200V$			65		pF
		$f = 1MHz, V_R = 400V$			50		
$R_{thJC}$	Junction to Case Thermal Resistance					2.2	$^\circ C/W$

## FRED Diodes (CR10/11, CR20/21, CR30/31) (per diode) Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V <sub>RRM</sub>	Peak Repetitive Reverse Voltage		600			V
I <sub>RM</sub>	Reverse Leakage Current	V <sub>R</sub> =600V			50	μA
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 30A V <sub>GE</sub> = 0V		1.45		V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 30A V <sub>R</sub> = 300V di/dt = 3000A/μs	T <sub>j</sub> = 25°C	80		ns
			T <sub>j</sub> = 125°C	105		
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 30A V <sub>R</sub> = 300V di/dt = 3000A/μs	T <sub>j</sub> = 25°C	1.7		μC
			T <sub>j</sub> = 125°C	2.5		
E <sub>r</sub>	Reverse Recovery Energy	I <sub>F</sub> = 30A V <sub>R</sub> = 300V di/dt = 3000A/μs	T <sub>j</sub> = 25°C	0.55		mJ
			T <sub>j</sub> = 125°C	0.8		
R <sub>thJC</sub>	Junction to Case Thermal Resistance				1.4	°C/W

### 3. Temperature sensor NTC

Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		22		kΩ
ΔR <sub>25</sub> /R <sub>25</sub>	Resistance tolerance			5	%
ΔB/B	Beta tolerance			3	
B <sub>25/100</sub>	T <sub>25</sub> = 298.16 K		3980		K

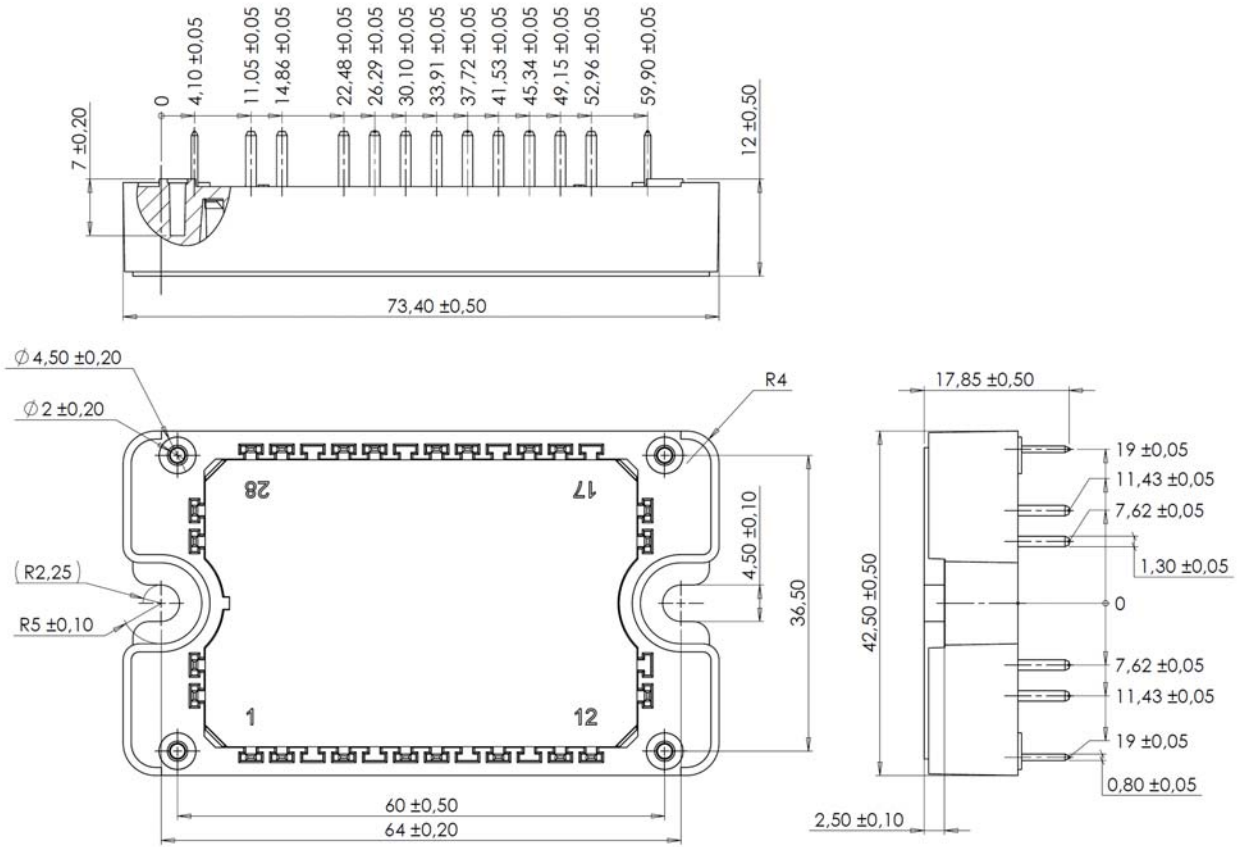
$$R_T = \frac{R_{25}}{\exp\left[B_{25/100}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]}$$

T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

### 4. package characteristics

Symbol	Characteristic	Min	Max	Unit		
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz	4000		V		
T <sub>J</sub>	Operating junction temperature range	Q10, Q20, Q30, Q12, Q22, Q32	-40	150	°C	
		CR12/13, CR22/23, CR32/33	-40	175		
		CR10/11, CR20/21, CR30/31	-40	175		
T <sub>JOP</sub>	Recommended junction temperature under switching conditions	-40	T <sub>Jmax</sub> -25			
T <sub>STG</sub>	Storage Temperature Range	-40	125			
T <sub>C</sub>	Operating Case Temperature	-40	125			
Torque	Mounting torque	To Heatsink	M4	2	3	N.m
Wt	Package Weight				110	g

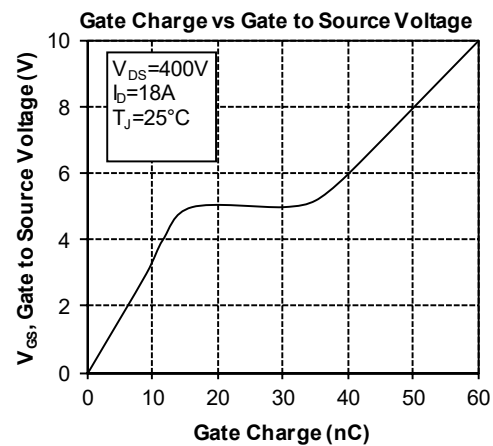
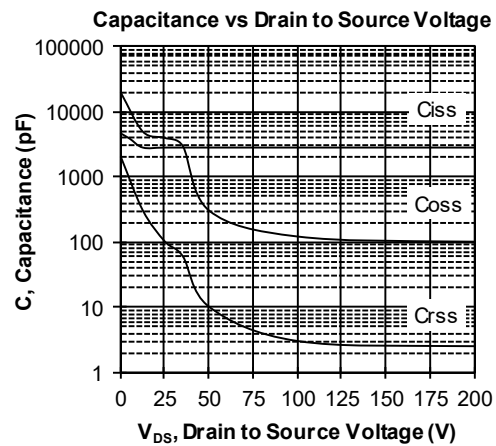
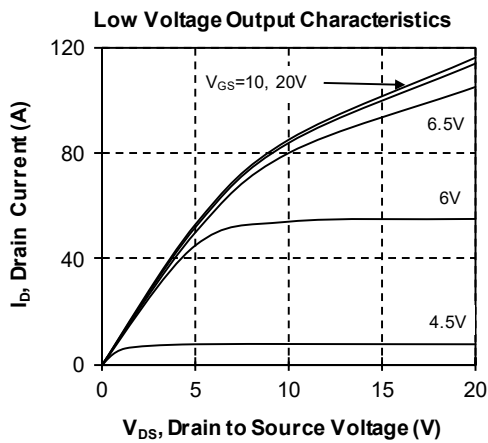
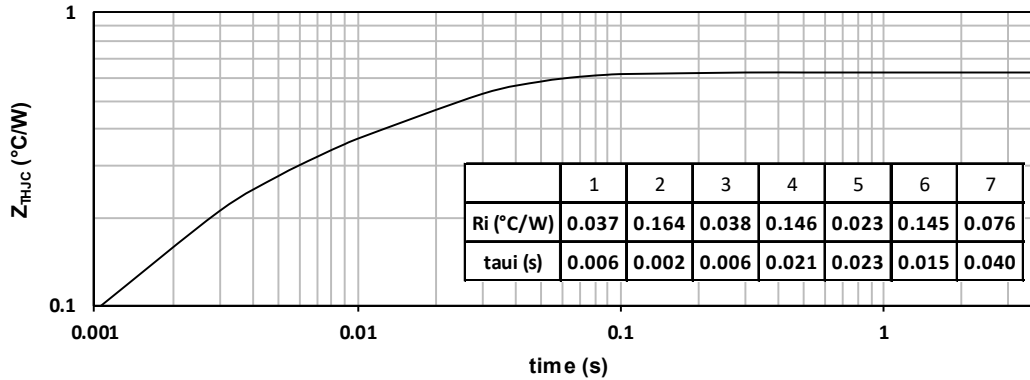
**Package outline (dimensions in mm)**



See application note 1906 - Mounting Instructions for SP3F Power Modules on [www.microsemi.com](http://www.microsemi.com)

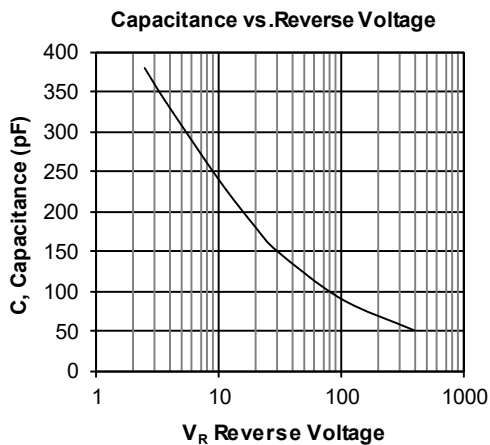
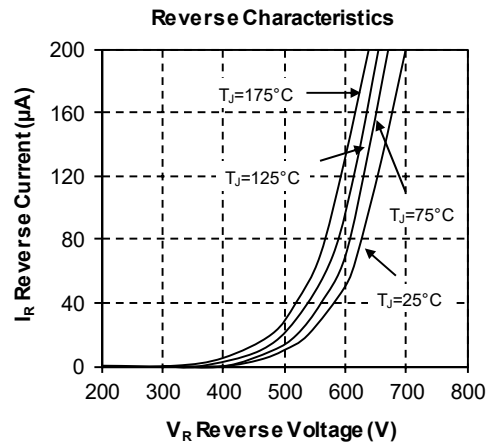
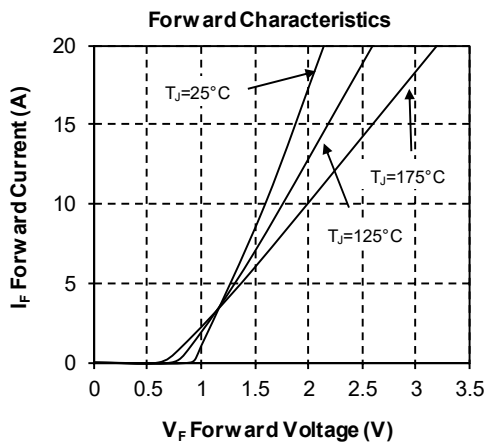
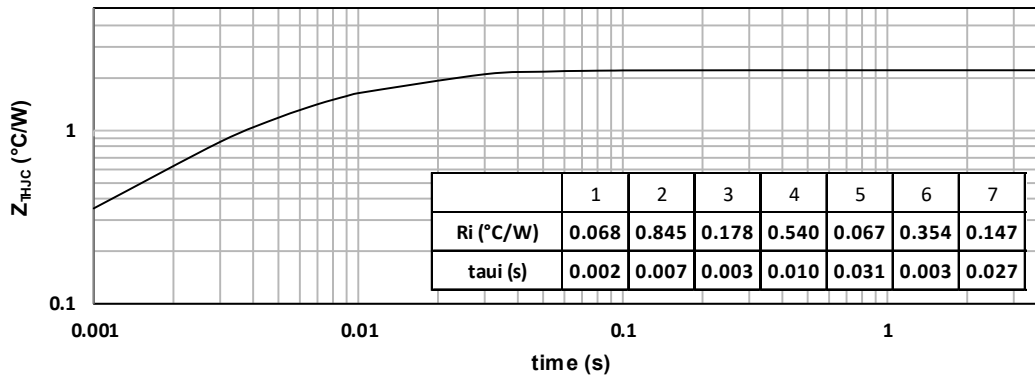
## Typical Super junction MOSFET Performance Curve (Per MOSFET)

Maximum thermal impedance



## Typical SiC diode Performance Curve (Per SiC diode)

Maximum thermal impedance



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